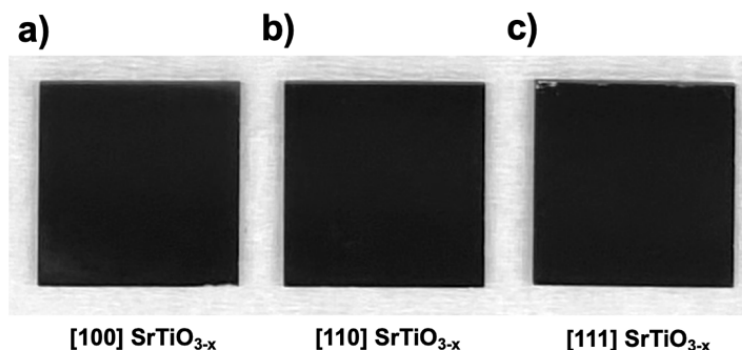


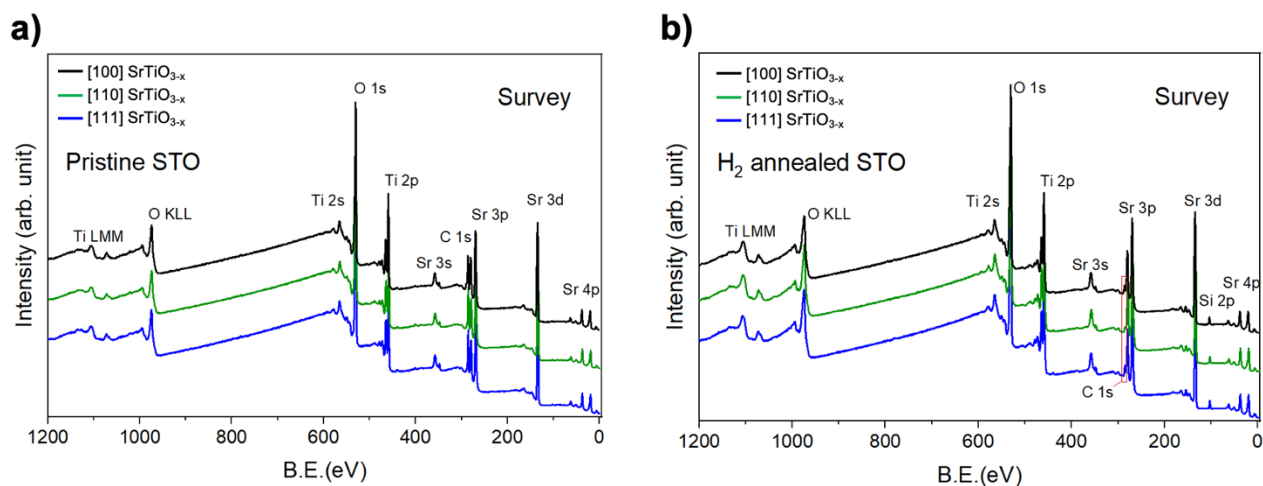
## Supporting Information (13 pages)

### Facets Control Charge Separation during Photoelectrochemical Water Oxidation with Strontium Titanate ( $\text{SrTiO}_3$ ) Single Crystals

Samutr Assavachin, Chengcan Xiao, Kathleen Becker, and Frank E. Osterloh\*



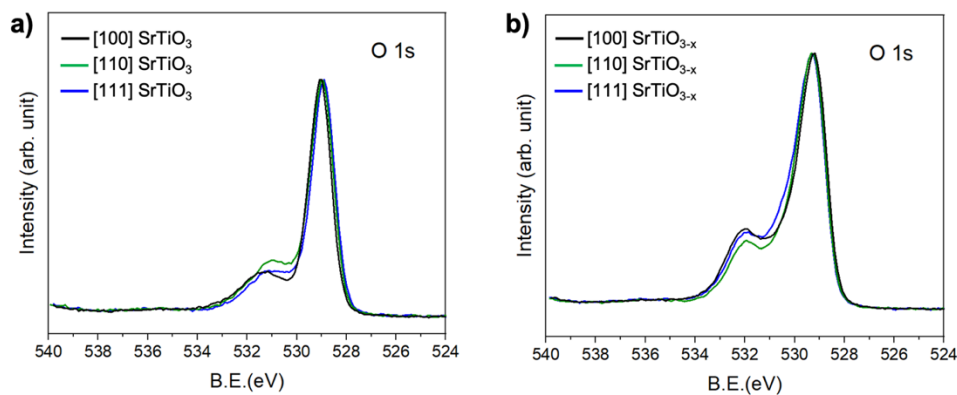
**Figure S1.** Photos of hydrogen-annealed  $\text{SrTiO}_{3-x}$  single crystals with a) (100), b) (110), and c) (111) facets. Crystals are  $1.0 \times 1.0 \text{ cm}^2$  large.



**Figure S2.** Survey scans of (100), (110), and (111) facets of the  $\text{SrTiO}_3$  single crystals before (a) and after (b)  $\text{H}_2$  annealing. A small Si 2p impurity peak at 102 eV is attributed to migration of Si species from the ceramic crucible used for the  $\text{H}_2$  annealing at  $1100^\circ\text{C}$ .

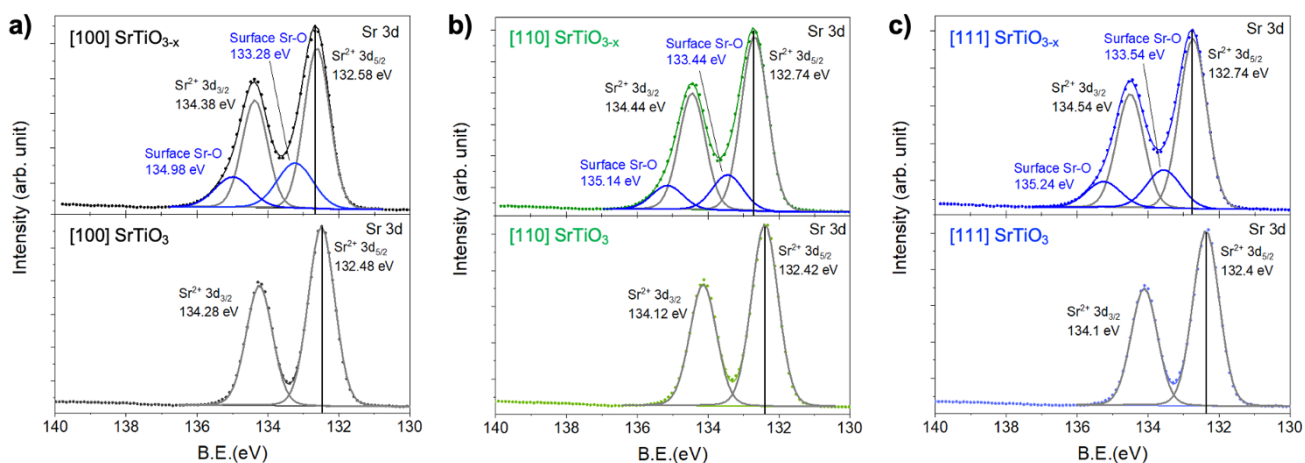
**Table S1.** XPS summary for SrTiO<sub>3</sub> single crystals before and after H<sub>2</sub> annealing.

O 1s	Lattice O			Sr-OH			Ti-OH			
	Position	Area	% area	Position	Area	% area	Position	Area	% area	
(100) SrTiO <sub>3</sub>	529.08	28455.580	73.4	530.18	1069.289	2.8	531.38	9233.749	23.8	
(100) SrTiO <sub>3-x</sub>	529.28	35511.050	58.4	530.38	8926.351	14.7	531.98	16413.640	27.0	
(110) SrTiO <sub>3</sub>	529.02	23034.040	66.3	530.02	742.980	2.1	531.12	10969.540	31.6	
(110) SrTiO <sub>3-x</sub>	529.24	37989.690	61.6	530.34	9944.254	16.1	531.94	13737.490	22.3	
(111) SrTiO <sub>3</sub>	528.90	25127.190	70.9	530.00	3591.105	10.1	531.3	6719.895	19.0	
(111) SrTiO <sub>3-x</sub>	529.34	34271.930	56.3	530.34	9944.254	19.8	531.94	14569.490	23.9	
Ti 2p	Ti <sup>4+</sup> 2p <sub>3/2</sub>			Ti <sup>4+</sup> 2p <sub>1/2</sub>		Ti <sup>3+</sup> 2p <sub>3/2</sub>			Ti <sup>3+</sup> 2p <sub>1/2</sub>	
	Position	Area	% area	Position	Area	Position	Area	% area	Position	Area
(100) SrTiO <sub>3</sub>	457.98	18701.270	-	463.68	9350.637	-	-	-	-	-
(100) SrTiO <sub>3-x</sub>	458.18	25095.470	89.2	463.98	12547.730	456.28	3053.007	10.8	462.18	1526.504
(110) SrTiO <sub>3</sub>	457.92	18364.61	-	463.62	9182.303	-	-	-	-	-
(110) SrTiO <sub>3-x</sub>	458.24	29828.030	91.0	464.04	14914.020	456.14	2958.796	9.0	462.24	1479.398
(111) SrTiO <sub>3</sub>	457.80	18670.750	-	463.60	9335.377	-	-	-	-	-
(111) SrTiO <sub>3-x</sub>	458.34	28265.560	91.7	464.04	14132.780	456.24	2565.564	8.3	462.24	1282.782
Sr 3d	Sr 3d <sub>5/2</sub>			Sr 3d <sub>3/2</sub>		Surface Sr 3d <sub>5/2</sub>			Surface Sr 3d <sub>3/2</sub>	
	Position	Area	% area	Position	Area	Position	Area	% area	Position	Area
(100) SrTiO <sub>3</sub>	132.48	20854.110	-	134.28	13902.81	-	-	-	-	-
(100) SrTiO <sub>3-x</sub>	132.58	21262.600	71.7	134.38	14175.140	133.28	8371.931	28.3	134.98	5581.315
(110) SrTiO <sub>3</sub>	132.48	19748.21	-	134.12	13165.48	-	-	-	-	-
(110) SrTiO <sub>3-x</sub>	132.74	26611.890	80.9	134.44	17741.350	133.44	6275.025	19.1	135.14	4183.37
(111) SrTiO <sub>3</sub>	132.40	18647.890	-	134.10	12431.990	-	-	-	-	-
(111) SrTiO <sub>3-x</sub>	132.74	22134.040	78.2	134.54	14756.100	133.54	6187.937	21.8	135.24	4125.312



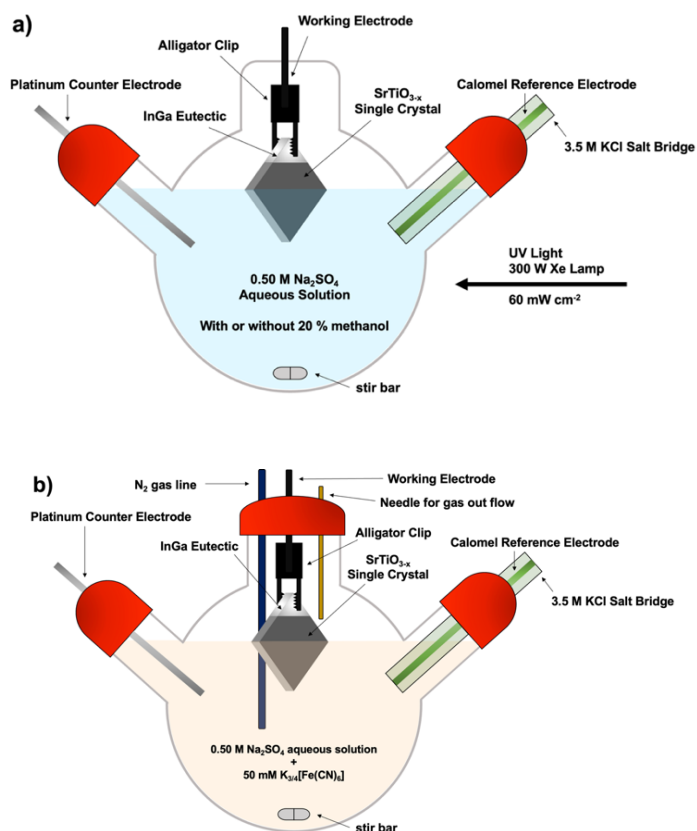
**Figure S3.** Overlapped high resolution O1s region for (100), (110), and (111) facets of  $\text{SrTiO}_3$  single crystal a) before and b) after  $\text{H}_2$  annealing.

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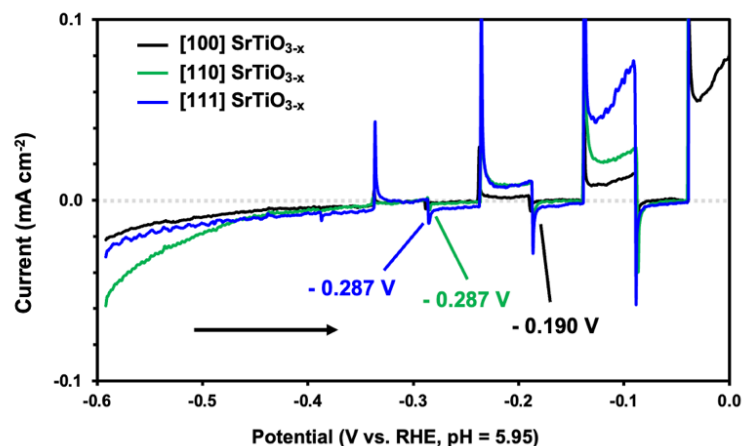


**Figure S4.** Sr 3d peak of a) (100), b) (110), and c) (111) facets of single crystal  $\text{SrTiO}_3$  after (top) and before  $\text{H}_2$  annealing (bottom).

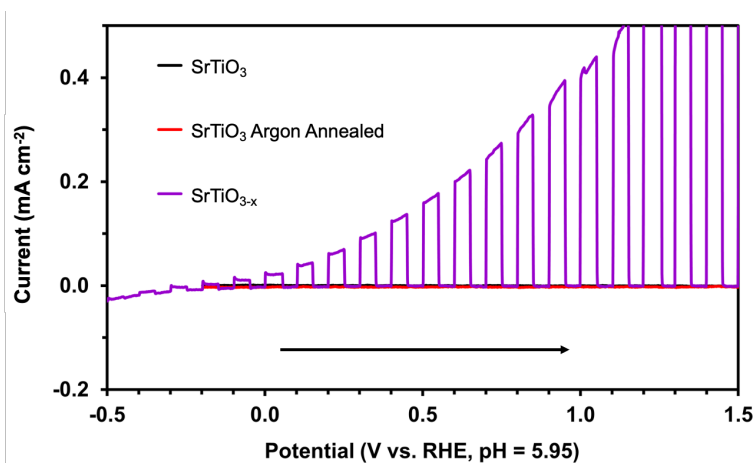
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**Figure S5.** a) Three-electrode setup for PEC measurements. The working electrode is a SrTiO<sub>3-x</sub> single crystal with InGa eutectic coating in contact to the stainless steel alligator clip. A 0.50 M Na<sub>2</sub>SO<sub>4</sub> aqueous electrolyte solution (pH = 5.95) exposed to open air is used under constant stirring. UV-light illumination occurs on the front side and is from a 300W Xe lamp with an intensity of 60 mW/cm<sup>2</sup> as measured with a GaN photodetector (220-380 nm). The working electrode area in contact with solution is 1.0 cm<sup>2</sup>. As only the front side responds to illumination (**Figure S10**), the area of 0.50 cm<sup>2</sup> was used to calculate the photocurrent density. b) For Mott-Schottky (MS) measurements the electrolyte is a nitrogen-bubbled 0.50 M Na<sub>2</sub>SO<sub>4</sub> aqueous electrolyte solution (pH = 5.95) with 50 mM equimolar K<sub>3/4</sub>[Fe(CN)<sub>6</sub>]. The solution was purged with N<sub>2</sub> gas for 30 minutes and bubbled with N<sub>2</sub> gas throughout all measurements with constant stirring at 200 rpm. No illumination was applied. The active area of the system is 1.0 cm<sup>2</sup> (both sides of the single crystal are in contact with the solution).

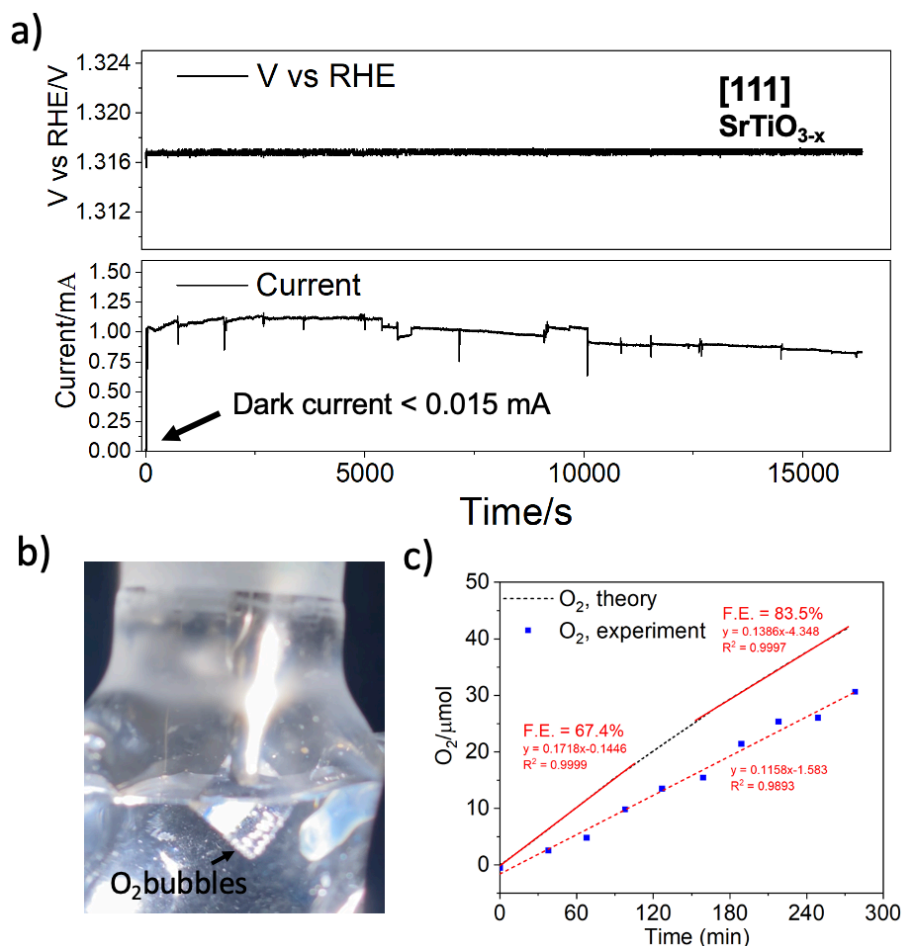


**Figure S6.** Magnified PEC scans for  $\text{SrTiO}_{3-x}$  crystals under UV illumination ( $60 \text{ mW cm}^{-2}$ ) from Xe Lamp in a)  $0.50 \text{ M Na}_2\text{SO}_4$  aqueous solution ( $\text{pH} = 5.95$ ). The scan direction is from negative to positive potential as indicated by the horizontal arrow. The active electrode area is  $0.50 \text{ cm}^2$ . Onset potentials were estimated graphically by interpolation of the photocurrent.

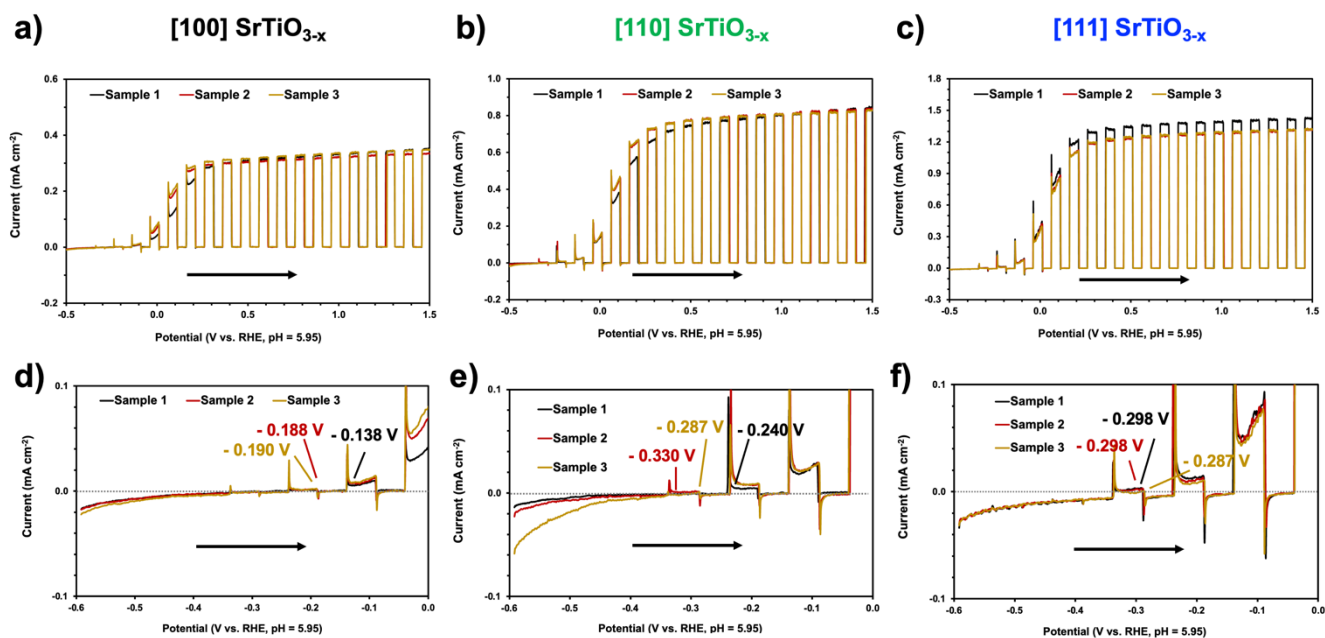


**Figure S7.** PEC scan in  $0.50 \text{ M Na}_2\text{SO}_4$  aqueous solution under  $60 \text{ mW cm}^{-2}$  UV light illumination for as-received, Ar-annealed, and  $\text{H}_2$ -annealed  $\text{SrTiO}_3$  single crystal with (111) exposed facet. The dataset was obtained from one single crystal sample. The sequence of measurements was as follows: 1<sup>st</sup> PEC measurement on the as-received  $\text{SrTiO}_3$  sample. 2<sup>nd</sup> PEC measurement on sample after argon annealing ( $500^\circ\text{C}$ ). 3<sup>rd</sup> PEC measurements on crystal after  $\text{H}_2$  annealing at  $1,110^\circ\text{C}$ . The argon annealing was an attempt to induce the formation of oxygen vacancies, but it was not successful, which is why  $\text{H}_2$  annealing was utilized. The scan direction is from negative to positive potential as indicated by the

horizontal arrow. The active electrode area is 0.50 cm<sup>2</sup>.



**Figure S8.** a) Chronoamperometry for H<sub>2</sub> annealed (111) SrTiO<sub>3-x</sub> single crystal at 1.33 V vs RHE in 0.50 M Na<sub>2</sub>SO<sub>4</sub> aqueous solution under UV illumination ( $\lambda < 400$  nm, 9 mW cm<sup>-2</sup>) from a Xe Lamp. The active electrode area is 0.50 cm<sup>2</sup>. Photocurrent variations are due to oxygen bubbles, see b) Photo of the working electrode. c) Faraday efficiency measurements (the solid line corresponds to theoretical O<sub>2</sub>) were conducted by separating the counter electrode from the working electrode / reference electrode compartment using a salt bridge filled with aqueous 3.5 M KCl. Before the measurement, the electrolyte in the cell was degassed with argon to remove residual air. During measurement, samples were periodically removed from the headspace with a gas tight syringe, injected into a calibrated gas chromatograph (*Varian*), and quantified using a thermal conductivity detector. The data was adjusted for air contamination using the observed nitrogen contribution from air.

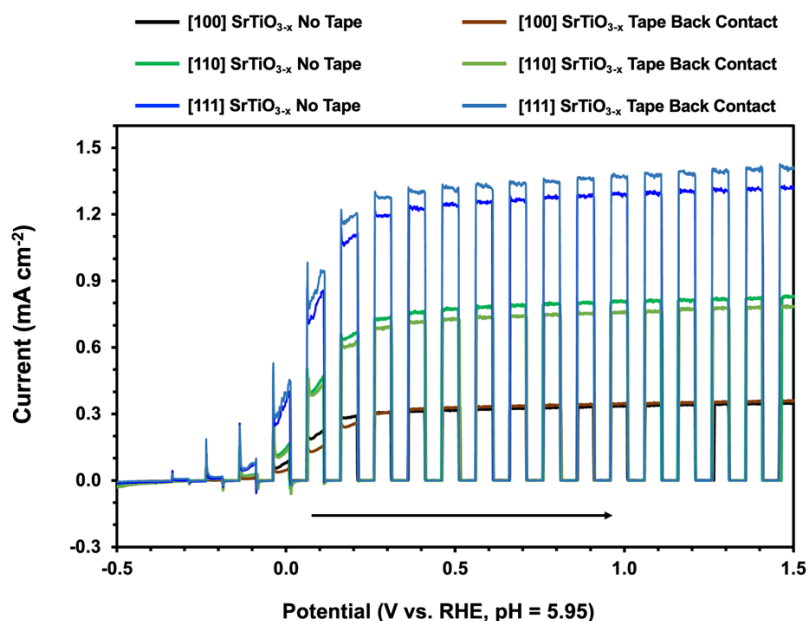


**Figure S9.** PEC for a) (100), b) (110), and c) (111)  $\text{SrTiO}_{3-x}$  single crystals in 0.50 M  $\text{Na}_2\text{SO}_4$  under UV light illumination ( $60 \text{ mW cm}^{-2}$ ) to determine the experimental error. The zoomed in plots reveal the photoonset potential,  $E_{\text{ON}}$ , for d) (100), e) (110), and f) (111)  $\text{SrTiO}_{3-x}$  single crystals. Sample 3 is also featured in **Figure 4**. The scan direction is from negative to positive potential as indicated by the horizontal arrow. The active electrode area is  $0.50 \text{ cm}^2$ .

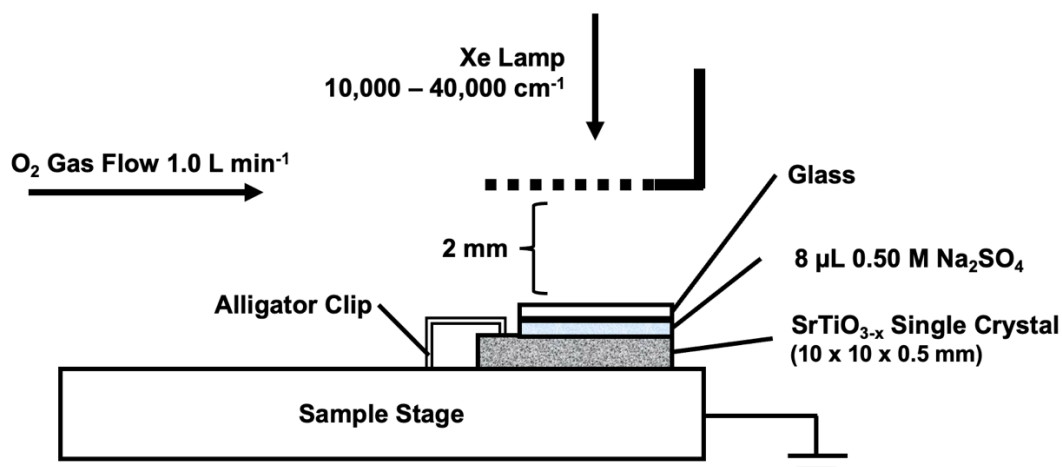
**Table S2.** Values and errors of photocurrent, photoonset, and photovoltage of three samples of (100, 110, 111) SrTiO<sub>3-x</sub> single crystals with different exposed facets corresponding to the data in **Figure S9**.

Crystal Orientation	(100) SrTiO <sub>3-x</sub>			(110) SrTiO <sub>3-x</sub>			(111) SrTiO <sub>3-x</sub>		
Sample	1	2	3	1	2	3	1	2	3
Current (mA cm <sup>-2</sup> )	0.342	0.328	0.341	0.821	0.823	0.814	1.413	1.300	1.304
Photoonset (V RHE)	-0.138	-0.188	-0.190	-0.240	-0.330	-0.287	-0.298	-0.298	-0.287
Photovoltage (V)	1.37	1.42	1.42	1.47	1.56	1.52	1.53	1.53	1.52
Average Current (mA cm <sup>-2</sup> )	0.337			0.819			1.357		
Current Standard Deviation (absolute, %)	0.01, 2.97			0.00, 0.00			0.08, 5.89		
Average Photoonset (V RHE)	-0.172			-0.286			-0.294		
Photoonset Standard Deviation (absolute, %)	0.03, 17.4			0.05, 17.5			0.01, 3.40		
Average Photovoltage (V)	1.40			1.52			1.52		
Photovoltage Standard Deviation (absolute, %)	0.03, 2.14			0.05, 3.29			0.01, 0.65		

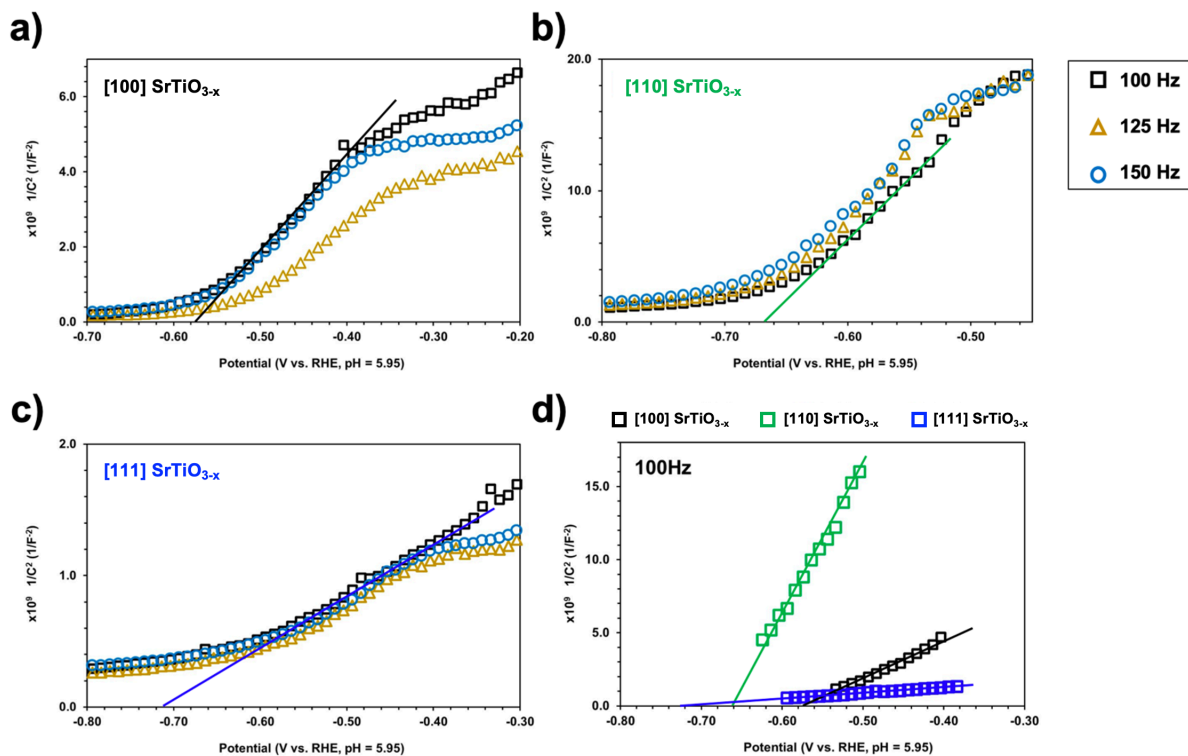




**Figure S10.** PEC of H<sub>2</sub>-annealed SrTiO<sub>3</sub> single crystals to evaluate the effect of polyester tape at the back contact. Conditions: InGa contact, 0.50 M Na<sub>2</sub>SO<sub>4</sub> aqueous solution under UV illumination (60 mW cm<sup>-2</sup>) from Xe lamp. The addition of tape to the crystal back reduces the photocurrent by <10%. As  $\sim$ 90% of the photocurrent is generated at the front side, current density calculations only need to consider the illuminated crystal front side. Scan direction is shown by the horizontal arrow.



**Figure S11.** Surface photovoltage spectroscopy Measurement configuration.



**Figure 12.** Mott Schottky plots at 100, 125, and 150 Hz in 0.50 M Na<sub>2</sub>SO<sub>4</sub> aqueous solution (pH = 5.95) with 50 mM equimolar K<sub>3/4</sub>[Fe(CN)<sub>6</sub>] under constant nitrogen purging without illumination for a) (100) SrTiO<sub>3-x</sub>, b) (110) SrTiO<sub>3-x</sub>, and c) (111) SrTiO<sub>3-x</sub> crystals. The crystal back is coated with InGa eutectic, as shown in **Figure S5b**. d) Comparison of the data at 100 Hz. Numerical values and calculation details are available in **Table S3**.

**Table S3.** Values obtained from Mott Schottky experiment and calculations for free electron density,  $N_D$ , flat band potential,  $E_{FB}$ , and conduction band edge,  $E_{CB}$ .

	(100) SrTiO <sub>3-x</sub>			(110) SrTiO <sub>3-x</sub>			(111) SrTiO <sub>3-x</sub>		
<b>Band Gap (eV)</b>	3.2			3.2			3.2		
<b>Dielectric Constant (<math>\epsilon</math>)</b>	300			300			300		
<b>Thickness (m)</b>	0.0005			0.0005			0.0005		
<b>Area (A / m<sup>2</sup>)</b>	0.0001			0.0001			0.0001		
<b>Effective Density of States (<math>N_{CB}</math> / cm<sup>-3</sup>)</b>	8.00 x 10 <sup>20</sup>			8.00 x 10 <sup>20</sup>			8.00 x 10 <sup>20</sup>		
<b>Frequency (Hz)</b>	100	125	150	100	125	150	100	125	150
<b>Potential (x-intercept)</b>	-0.570	-0.542	-0.579	-0.666	-0.687	-0.699	-0.725	-0.712	-0.720
<b>Flatband Potential (<math>E_{FB}</math> / V vs RHE)</b>	-0.596	-0.567	-0.605	-0.692	-0.713	-0.725	-0.751	-0.738	-0.745
<b>Slope (C<sup>-2</sup> x 10<sup>9</sup>)</b>	26.467	18.233	22.800	96.329	92.204	86.322	3.831	3.615	3.724
<b>Free Electron Density (<math>N_D</math> / m<sup>-3</sup>)</b>	1.78 x 10 <sup>25</sup>	2.58 x 10 <sup>25</sup>	2.06 x 10 <sup>25</sup>	4.88 x 10 <sup>24</sup>	5.10 x 10 <sup>24</sup>	5.44 x 10 <sup>24</sup>	1.23 x 10 <sup>26</sup>	1.30 x 10 <sup>26</sup>	1.26 x 10 <sup>26</sup>
<b>Free Electron Density (<math>N_D</math> / cm<sup>-3</sup>)</b>	1.78 x 10 <sup>19</sup>	2.58 x 10 <sup>19</sup>	2.06 x 10 <sup>19</sup>	4.88 x 10 <sup>18</sup>	5.10 x 10 <sup>18</sup>	5.44 x 10 <sup>18</sup>	1.23 x 10 <sup>20</sup>	1.30 x 10 <sup>20</sup>	1.26 x 10 <sup>20</sup>
<b>Conduction Band Edge (<math>E_{CB}</math> / V vs RHE)</b>	-0.69	-0.66	-0.70	-0.82	-0.84	-0.85	-0.80	-0.78	-0.79
<b>Valence Band Edge (<math>E_{VB}</math> / V vs RHE)</b>	2.51	2.54	2.50	2.38	2.36	2.35	2.40	2.42	2.41
<b>Junctions</b>	SrTiO <sub>3</sub> / O <sub>2</sub> /H <sub>2</sub> O			SrTiO <sub>3</sub> / O <sub>2</sub> /H <sub>2</sub> O			SrTiO <sub>3</sub> / O <sub>2</sub> /H <sub>2</sub> O		
<b>E<sup>0</sup> (V vs RHE)</b>	1.23			1.23			1.23		
<b>Built-in Potential, <math>V_{bi}</math> (V)</b>	1.83	1.80	1.83	1.92	1.94	1.95	1.98	1.97	1.97
<b>Depletion layer width (nm)</b>	58.0	47.8	53.9	114	112	108	23.0	22.3	22.6

Mott-Schottky measurements were performed using a Gamry Reference 600 Potentiostat at an applied frequency of 100-150 Hz. The space charge capacitance,  $C$ , varies with the applied potential over the depletion layer as determined by the Mott-Schottky equation:

$$\frac{1}{C^2} = \left( \frac{2}{\epsilon \epsilon_0 A^2 e N_D} \right) \left( V - E_{FB} - \frac{k_B T}{e} \right)$$

Here,  $e$  is the electron charge,  $\epsilon$  is the dielectric constant,  $\epsilon_0$  is the permittivity of a vacuum,  $N_D$  is the free electron density,  $V$  is the applied bias,  $E_{FB}$  is the flatband potential,  $k$  is the Boltzmann constant,  $T$  is the temperature, and  $A$  is the surface area of the film in contact with the electrolyte. A plot of  $C^{-2}$  versus  $V$  yields a straight line with a slope that can be used to determine  $N_D$ .

Slope =  $(2/e \epsilon \epsilon_0 N_D A^2)$ ; Given  $\epsilon$  of  $\text{SrTiO}_3 = 300$ ,  $A = 0.0001 \text{ m}^2$ ,  $\epsilon_0 = 8.8541 \times 10^{-12} \text{ C m}^{-1} \text{ V}^{-1}$ , and  $e = 1.60 \times 10^{-19} \text{ C}$ , for (111)  $\text{SrTiO}_{3-x}$  at 100 Hz, the slope =  $3.83 \times 10^9 \text{ C}^{-2} \text{ F}^2$  and the calculated  $N_D$  value of  $1.23 \times 10^{20} \text{ cm}^{-3}$  was obtained. Using the Mott-Schottky equation, the flatband potential is determined from the intercept with the x-axis on the linear plot of  $C^{-2}$  versus  $V$  and converted from SCE to RHE. The x-axis intercept was -0.725 V RHE at pH = 5.95, and therefore  $E_{FB}$  is -0.751 V vs RHE.

The conduction band position,  $E_{CB}$ , is determined from the equation for a n-type semiconductor:  $E_{CB} = E_{FB} + k_B T \times \ln(N_D / N_{CB})$  where the effective density of states,  $N_{CB}$ , for doped  $\text{SrTiO}_3$  was found to be approximately  $8.00 \times 10^{20} \text{ cm}^{-3}$ .<sup>2</sup> Therefore, for (111)  $\text{SrTiO}_{3-x}$  at 100 Hz,  $E_{CB} = -0.80 \text{ V RHE}$ .

Strontium titanate has a band gap value of  $3.2 \text{ eV}$ <sup>3</sup> and the position of the valence band can be determined by adding the bandgap value to the conduction band position,  $E_{CB}$ . The valence band edge is therefore at approximately +2.40 V RHE at pH = 5.95.

The space charge region (SCR), or the depletion layer width,  $w$ , is calculated using the following formula:

$$w = \sqrt{\frac{2\epsilon\epsilon_0 V_{bi}}{eN_D}}$$

Here,  $e$  is the electron charge,  $\epsilon$  is the dielectric constant,  $\epsilon_0$  is the permittivity of a vacuum,  $N_D$  is the free electron density, and  $V_{bi}$  is the built in potential.

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